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IS25LP512M IS25WP512M

512Mb

**SERIAL FLASH MEMORY 133MHZ MULTI I/O SPI &
QUAD I/O QPI DTR INTERFACE**

ADVANCED DATA SHEET

512Mb

SERIAL FLASH MEMORY 133MHZ MULTI I/O SPI & QUAD I/O QPI DTR INTERFACE

ADVANCED INFORMATION

FEATURES

- **Industry Standard Serial Interface**
 - IS25LP512M: 512Mbit/64Mbyte
 - IS25WP512M: 512Mbit/64Mbyte
 - 3 or 4 Byte Addressing Mode
 - Supports Standard SPI, Fast, Dual, Dual I/O, Quad, Quad I/O, SPI DTR, Dual I/O DTR, Quad I/O DTR, and QPI
 - Software & Hardware Reset
 - Supports Serial Flash Discoverable Parameters (SFDP)
- **High Performance Serial Flash (SPI)**
 - 80MHz Normal Read
 - Up to 133Mhz Fast Read
 - Up to 80MHz DTR (Dual Transfer Rate)
 - Equivalent Throughput of 532 Mb/s
 - Selectable Dummy Cycles
 - Configurable Drive Strength
 - Supports SPI Modes 0 and 3
 - More than 100,000 Erase/Program Cycles
 - More than 20-year Data Retention
- **Flexible & Efficient Memory Architecture**
 - Chip Erase with Uniform Sector/Block Erase (4/32/64KB or 4/32/256 KB)⁽²⁾
 - Program 1 to 256 or 512 Byte per Page⁽²⁾
 - Program/Erase Suspend & Resume
- **Efficient Read and Program modes**
 - Low Instruction Overhead Operations
 - Continuous Read 8/16/32/64 Byte Burst Wrap
 - Selectable Burst Length
 - QPI for Reduced Instruction Overhead
 - AutoBoot Operation
 - Data Learning Pattern for training in DTR operation
- **Low Power with Wide Temp. Ranges**
 - Single Voltage Supply
 - IS25LP: 2.30V to 3.60V
 - IS25WP: 1.65V to 1.95V
 - 7 mA Active Read Current
 - 10 μ A Standby Current
 - 1 μ A Deep Power Down
 - Temp Grades:
 - Extended: -40°C to +105°C
 - Auto Grade (A3): -40°C to +125°C
- **Advanced Security Protection**
 - Software and Hardware Write Protection
 - Advanced Sector/Block Protection
 - Top/Bottom Block Protection
 - Power Supply Lock Protection
 - 4x256 Byte Dedicated Security Area with OTP User-lockable Bits
 - 128 bit Unique ID for Each Device (Call Factory)
- **Industry Standard Pin-out & Packages⁽¹⁾**
 - M = 16-pin SOIC 300mil⁽²⁾
 - L = 8-contact WSON 8x6mm⁽²⁾
 - G = 24-ball TFBGA 6x8mm (4x6 ball array)⁽²⁾
 - H = 24-ball TFBGA 6x8mm (5x5 ball array)⁽²⁾

Notes:

1. Call Factory for other package options available.
2. For optional 512 Byte Page size with 256 KB Block size, see the Ordering Information.

GENERAL DESCRIPTION

The IS25LP512M and IS25WP512M Serial Flash memory offers a versatile storage solution with high flexibility and performance in a simplified pin count package. ISSI's "Industry Standard Serial Interface" Flash is for systems that require limited space, a low pin count, and low power consumption. The device is accessed through a 4-wire SPI Interface consisting of a Serial Data Input (SI), Serial Data Output (SO), Serial Clock (SCK), and Chip Enable (CE#) pins, which can also be configured to serve as multi-I/O (see pin descriptions).

The device supports Dual and Quad I/O as well as standard, Dual Output, and Quad Output SPI. Clock frequencies of up to 133MHz allow for equivalent clock rates of up to 532MHz (133MHz x 4) which equates to 66.5Mbytes/s of data throughput. The IS25xE series of Flash adds support for DTR (Double Transfer Rate) commands that transfer addresses and read data on both edges of the clock. These transfer rates can outperform 16-bit Parallel Flash memories allowing for efficient memory access to support XIP (execute in place) operation.

The memory array is organized into programmable pages of 256/512 bytes. This family supports page program mode where 1 to 256/512 bytes of data are programmed in a single command.

QPI (Quad Peripheral Interface) supports 2-cycle instruction further reducing instruction times. Pages can be erased in groups of 4Kbyte sectors, 32Kbyte blocks, 64K/256Kbyte blocks, and/or the entire chip. The uniform sector and block architecture allows for a high degree of flexibility so that the device can be utilized for a broad variety of applications requiring solid data retention.

Item which must be waived from the initial Engineering Sample

Initial Engineering sample does not meet below item in the specification, but it will be fixed in the production version.

1. DTR Function :

DTR Read Function does not work for initial Engineering Sample. It will be fixed in the production version.

TABLE OF CONTENTS

FEATURES	2
GENERAL DESCRIPTION	3
TABLE OF CONTENTS	4
1. PIN CONFIGURATION	8
2. PIN DESCRIPTIONS	9
3. BLOCK DIAGRAM	11
4. SPI MODES DESCRIPTION	12
5. SYSTEM CONFIGURATION	14
5.1 BLOCK/SECTOR ADDRESSES	14
5.2 Serial Flash Discoverable Parameters	16
6. REGISTERS	22
6.1 STATUS REGISTER	22
6.2 FUNCTION REGISTER	27
6.3 READ REGISTER AND EXTENDED REGISTER	28
6.3.1 READ REGISTER	28
6.3.2 EXTENDED READ REGISTER	30
6.4 AUTOBOOT REGISTER	32
6.5 BANK ADDRESS REGISTER	33
6.6 ADVANCED SECTOR/BLOCK PROTECTION (ASP) RELATED REGISTER	34
6.6.1 ADVANCED SECTOR/BLOCK PROTECTION REGISTER (ASPR)	34
6.6.2 PASSWORD REGISTER	35
6.6.3 PPB LOCK REGISTER	35
6.6.4 PPB REGISTER	36
6.6.5 DYB REGISTER	36
6.6.6 DATA LEARNING PATTERN REGISTER	37
7. PROTECTION MODE	38
7.1 HARDWARE WRITE PROTECTION	38
7.2 SOFTWARE WRITE PROTECTION	38
7.2.1 BLOCK PROTECTION BITS	38
7.2.2 ADVANCED SECTOR/BLOCK PROTECTION (ASP)	39
8. DEVICE OPERATION	47
8.1 COMMAND OVERVIEW	47
8.2 COMMAND SET SUMMARY	48
8.3 NORMAL READ OPERATION (NORD, 03h or 4NORD, 13h)	57
8.4 FAST READ OPERATION (FRD, 0Bh or 4FRD, 0Ch)	60
8.5 HOLD OPERATION	64
8.6 FAST READ DUAL I/O OPERATION (FRDIO, BBh or 4FRDIO, BCh)	65
8.7 FAST READ DUAL OUTPUT OPERATION (FRDO, 3Bh or 4FRDO, 3Ch)	69

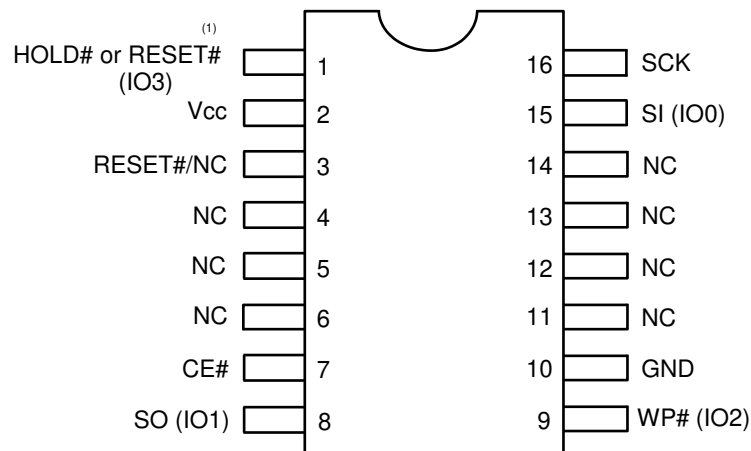
8.8 FAST READ QUAD OUTPUT OPERATION (FRQO, 6Bh or 4FRQO 6Ch)	72
8.9 FAST READ QUAD I/O OPERATION (FRQIO, EBh or 4FRQIO, ECh).....	75
8.10 PAGE PROGRAM OPERATION (PP, 02h or 4PP, 12h).....	82
8.11 QUAD INPUT PAGE PROGRAM OPERATION (PPQ, 32h/38h or 4PPQ, 34h/3Eh)	85
8.12 ERASE OPERATION	86
8.13 SECTOR ERASE OPERATION (SER, D7h/20h or 4SER, 21h)	87
8.14 BLOCK ERASE OPERATION (BER32K:52h or 4BER32K:5Ch, BER64K/256K:D8h or 4BER64K/256K:DCh)	89
8.15 CHIP ERASE OPERATION (CER, C7h/60h)	92
8.16 WRITE ENABLE OPERATION (WREN, 06h)	93
8.17 WRITE DISABLE OPERATION (WRDI, 04h).....	94
8.18 READ STATUS REGISTER OPERATION (RDSR, 05h)	95
8.19 WRITE STATUS REGISTER OPERATION (WRSR, 01h).....	96
8.20 READ FUNCTION REGISTER OPERATION (RDFR, 48h)	97
8.21 WRITE FUNCTION REGISTER OPERATION (WRFR, 42h).....	98
8.22 ENTER QUAD PERIPHERAL INTERFACE (QPI) MODE OPERATION (QIOEN,35h; QIODI,F5h) ..	99
8.23 PROGRAM/ERASE SUSPEND & RESUME.....	100
8.24 ENTER DEEP POWER DOWN (DP, B9h)	103
8.25 RELEASE DEEP POWER DOWN (RDPD, ABh).....	104
8.26 SET READ PARAMETERS OPERATION (SRPNV: 65h, SRPV: C0h/63h)	105
8.27 SET EXTENDED READ PARAMETERS OPERATION (SERPNV: 85h, SERPV: 83h)	107
8.28 READ READ PARAMETERS OPERATION (RDRP, 61h)	108
8.29 READ EXTENDED READ PARAMETERS OPERATION (RDERP, 81h).....	109
8.30 CLEAR EXTENDED READ REGISTER OPERATION (CLERP, 82h).....	110
8.31 READ PRODUCT IDENTIFICATION (RDID, ABh)	111
8.32 READ PRODUCT IDENTIFICATION BY JEDEC ID OPERATION (RDJDID, 9Fh; RDJDIDQ, AFh)	113
8.33 READ DEVICE MANUFACTURER AND DEVICE ID OPERATION (RDMDID, 90h)	114
8.34 READ UNIQUE ID NUMBER (RUID, 4Bh)	115
8.35 READ SFDP OPERATION (RDSFDP, 5Ah)	116
8.36 NO OPERATION (NOP, 00h)	116
8.37 SOFTWARE RESET (RESET-ENABLE (RSTEN, 66h) AND RESET (RST, 99h)) AND HARDWARE RESET	117
8.38 SECURITY INFORMATION ROW.....	118
8.39 INFORMATION ROW ERASE OPERATION (IRER, 64h)	119
8.40 INFORMATION ROW PROGRAM OPERATION (IRP, 62h)	120
8.41 INFORMATION ROW READ OPERATION (IRRD, 68h)	121
8.42 FAST READ DTR MODE OPERATION (FRDTR, 0Dh or 4FRDTR, 0Eh).....	122
8.43 FAST READ DUAL IO DTR MODE OPERATION (FRDDTR, BDh or 4FRDDTR, BEh)	127
8.44 FAST READ QUAD IO DTR MODE OPERATION IN SPI MODE (FRQDTR, EDh or 4FRQDTR, EEh)	131

8.45	SECTOR LOCK/UNLOCK FUNCTIONS	139
8.46	AUTOBOOT	142
8.47	READ BANK ADDRESS REGISTER OPERATION (RDBR: 16h/C8h)	146
8.48	WRITE BANK ADDRESS REGISTER OPERATION (WRBRNV: 18h, WRBRV: 17h/C5h)	147
8.49	ENTER 4-BYTE ADDRESS MODE OPERATION (EN4B, B7h)	148
8.50	EXIT 4-BYTE ADDRESS MODE OPERATION (EX4B, 29h)	149
8.51	READ DYB OPERATION (RDDYB, FAh or 4RDDYB, E0h)	150
8.52	WRITE DYB OPERATION (WRDYB, FBh or 4WRDYB, E1h)	152
8.53	READ PPB OPERATION (RDPPB, FCh or 4RDPPB, E2h)	154
8.54	PROGRAM PPB OPERATION (PGPPB, FDh or 4PGPPB, E3h)	155
8.55	ERASE PPB OPERATION (ERPPB, E4h)	157
8.56	READ ASP OPERATION (RDASP, 2Bh)	158
8.57	PROGRAM ASP OPERATION (PGASP, 2Fh)	159
8.58	READ PPB LOCK BIT OPERATION (RDPLB, A7h)	160
8.59	WRITE PPB LOCK BIT OPERATION (WRPLB, A6h)	161
8.60	SET FREEZE BIT OPERATION (SFRZ, 91h)	162
8.61	READ PASSWORD OPERATION (RDPWD, E7h)	163
8.62	PROGRAM PASSWORD OPERATION (PGPWD, E8h)	164
8.63	UNLOCK PASSWORD OPERATION (UNPWD, E9h)	165
8.64	GANG SECTOR/BLOCK LOCK OPERATION (GBLK, 7Eh)	166
8.65	GANG SECTOR/BLOCK UNLOCK OPERATION (GBUN, 98h)	167
8.66	DATA LEARNING PATTERN (DLP)	168
8.67	PROGRAM NVDLR OPERATION (PNVDLR, 43h)	171
8.68	WRITE VDLR OPERATION (WRVDLR, 4Ah)	172
8.69	READ DLP OPERATION (RDDLP, 41h)	173
9.	ELECTRICAL CHARACTERISTICS	174
9.1	ABSOLUTE MAXIMUM RATINGS ⁽¹⁾	174
9.2	OPERATING RANGE	174
9.3	DC CHARACTERISTICS	175
9.4	AC MEASUREMENT CONDITIONS	176
9.5	P _{in} CAPACITANCE	176
9.6	AC CHARACTERISTICS	177
9.7	SERIAL INPUT/OUTPUT TIMING	179
9.8	POWER-UP AND POWER-DOWN	181
9.9	PROGRAM/ERASE PERFORMANCE	182
9.10	RELIABILITY CHARACTERISTICS	182
10.	PACKAGE TYPE INFORMATION	183
10.1	8-CONTACT ULTRA-THIN SMALL OUTLINE NO-LEAD (WSON) PACKAGE 8x6mm (L)	183
10.2	16-LEAD PLASTIC SMALL OUTLINE PACKAGE (300 MILS BODY WIDTH) (M)	184
10.3	24-BALL THIN PROFILE FINE PITCH BGA 6x8mm 4x6 BALL ARRAY (G)	185

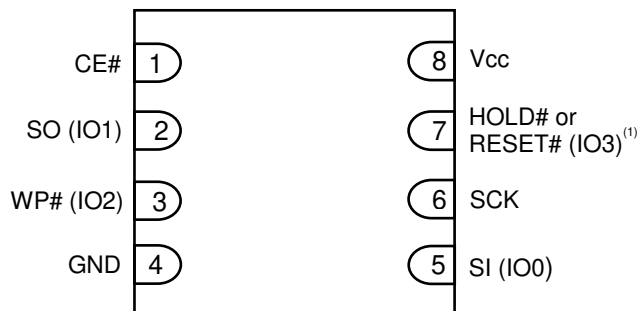


10.4 24-BALL THIN PROFILE FINE PITCH BGA 6x8mm 5x5 BALL ARRAY (H)	186
11. ORDERING INFORMATION – Valid Part Numbers.....	187

1. PIN CONFIGURATION

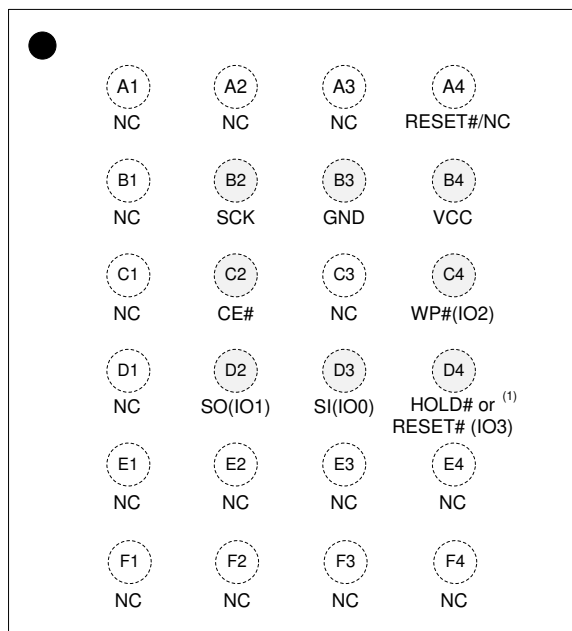


16-pin SOIC 300mil



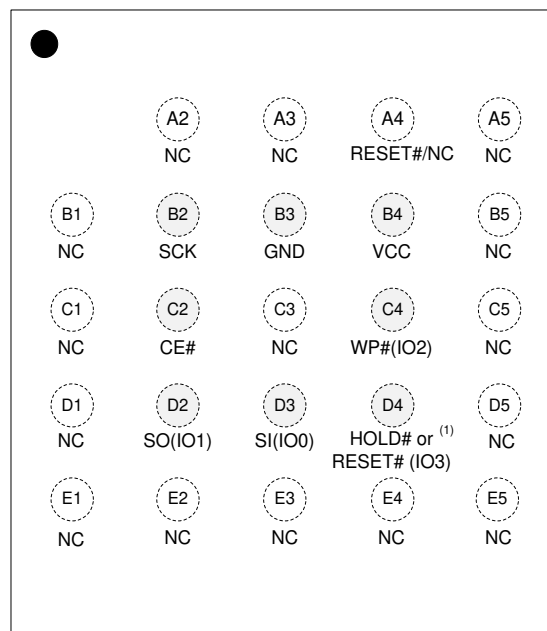
8-contact WSON 8x6mm

Top View, Balls Facing Down



24-ball TFBGA 6x8mm (4x6 ball array)
(Package: G)

Top View, Balls Facing Down



24-ball TFBGA 6x8mm (5x5 ball array)
(Package: H)

Note:

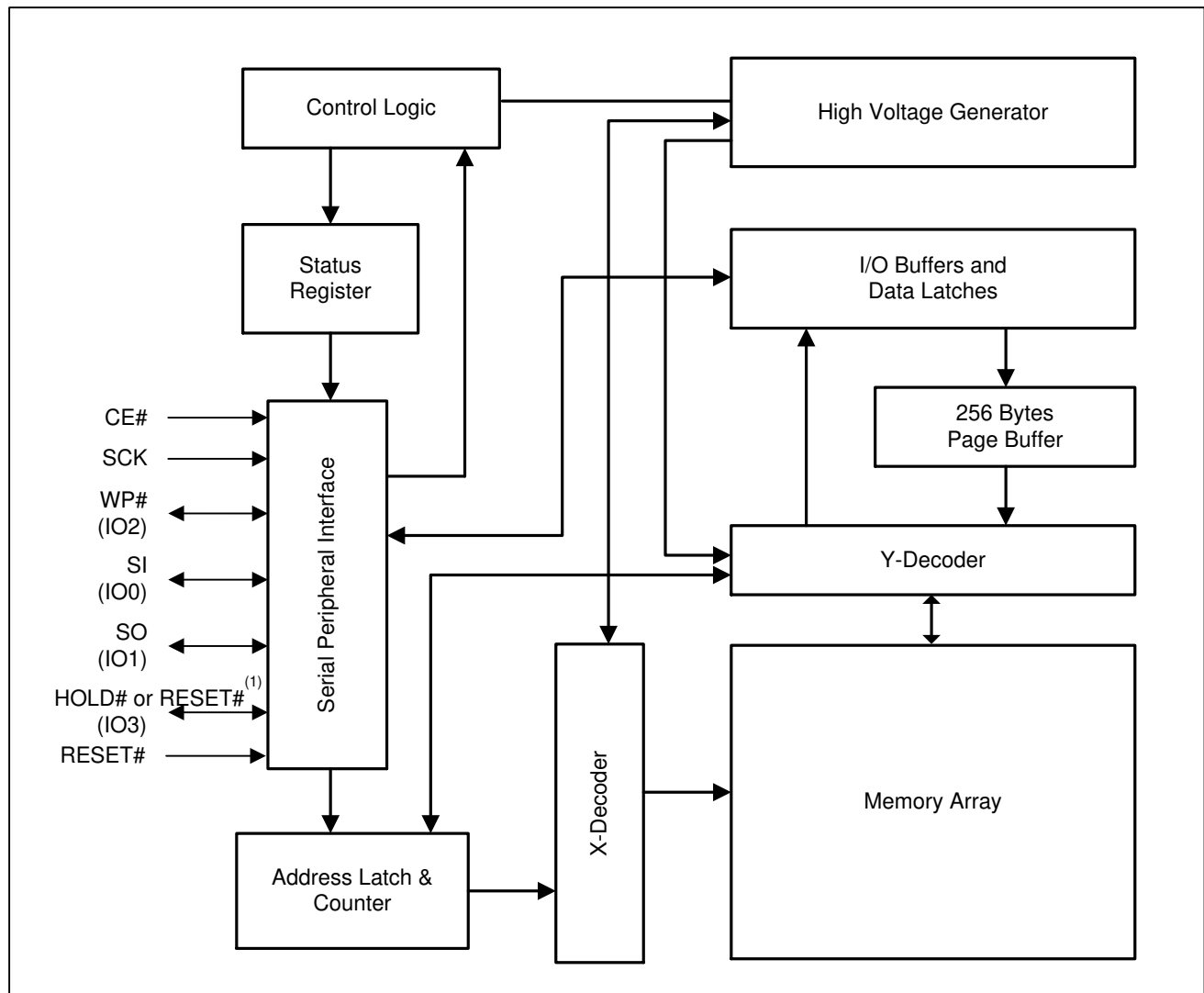
1. The pin can be configured as Hold# or Reset# by setting P7 bit of the Read Register. Pin default is Hold# (IO3).

2. PIN DESCRIPTIONS

SYMBOL	TYPE	DESCRIPTION
CE#	INPUT	<p>Chip Enable: The Chip Enable (CE#) pin enables and disables the devices operation. When CE# is high the device is deselected and output pins are in a high impedance state. When deselected the devices non-critical internal circuitry power down to allow minimal levels of power consumption while in a standby state.</p> <p>When CE# is pulled low the device will be selected and brought out of standby mode. The device is considered active and instructions can be written to, data read, and written to the device. After power-up, CE# must transition from high to low before a new instruction will be accepted.</p> <p>Keeping CE# in a high state deselects the device and switches it into its low power state. Data will not be accepted when CE# is high.</p>
SI (IO0), SO (IO1)	INPUT/OUTPUT	<p>Serial Data Input, Serial Output, and IOs (SI, SO, IO0, and IO1):</p> <p>This device supports standard SPI, Dual SPI, and Quad SPI operation. Standard SPI instructions use the unidirectional SI (Serial Input) pin to write instructions, addresses, or data to the device on the rising edge of the Serial Clock (SCK). Standard SPI also uses the unidirectional SO (Serial Output) to read data or status from the device on the falling edge of the serial clock (SCK).</p> <p>In Dual and Quad SPI mode, SI and SO become bidirectional IO pins to write instructions, addresses or data to the device on the rising edge of the Serial Clock (SCK) and read data or status from the device on the falling edge of SCK. Quad SPI instructions use the WP# and HOLD# pins as IO2 and IO3 respectively.</p>
WP# (IO2)	INPUT/OUTPUT	<p>Write Protect/Serial Data IO (IO2): The WP# pin protects the Status Register from being written in conjunction with the SRWD bit. When the SRWD is set to "1" and the WP# is pulled low, the Status Register bits (SRWD, QE, BP3, BP2, BP1, BP0) are write-protected and vice-versa for WP# high. When the SRWD is set to "0", the Status Register is not write-protected regardless of WP# state.</p> <p>When the QE bit is set to "1", the WP# pin (Write Protect) function is not available since this pin is used for IO2.</p>
HOLD# (IO3) or RESET# (IO3)	INPUT/OUTPUT	<p>HOLD# or RESET#/Serial Data IO (IO3): When the QE bit of Status Register is set to "1", HOLD# pin or RESET# is not available since it becomes IO3.</p> <p>Most packages except for 16-pin SOIC and 24-ball BGA:</p> <p>When QE=0, the pin acts as HOLD# or RESET# and either one can be selected by the P7 bit setting in Read Register. HOLD# will be selected if P7=0 (Default) and RESET# will be selected if P7=1.</p> <p>16-pin SOIC and 24-ball BGA packages :</p> <ul style="list-style-type: none"> - When QE=0 and Dedicated RESET# is Enabled (Default), the pin acts as HOLD# regardless of the P7 bit setting in Read Register. - When QE=0 and Dedicated RESET# is Disabled, the pin acts as HOLD# or RESET# and either one can be selected by the P7 bit setting in Read Register. HOLD# will be selected if P7=0 (Default) and RESET# will be selected if P7=1. <p>The HOLD# pin allows the device to be paused while it is selected. It pauses serial communication by the master device without resetting the serial sequence. The HOLD# pin is active low. When HOLD# is in a low state and CE# is low, the SO pin will be at high impedance. Device operation can resume when HOLD# pin is brought to a high state.</p>

SYMBOL	TYPE	DESCRIPTION
RESET#	INPUT/OUTPUT	<p>RESET#: This dedicated RESET# is available in 16-pin SOIC and 24-ball BGA packages.</p> <p>The RESET# pin is a hardware RESET signal. When RESET# is driven HIGH, the memory is in the normal operating mode. When RESET# is driven LOW, the memory enters reset mode and output is High-Z. If RESET# is driven LOW while an internal WRITE, PROGRAM, or ERASE operation is in progress, data may be lost.</p> <p>Dedicated RESET# function can be Disabled when bit 0 of Function Register = 1. It has an internal pull-up resistor and may be left floating if not used.</p>
SCK	INPUT	Serial Data Clock: Synchronized Clock for input and output timing operations.
Vcc	POWER	Power: Device Core Power Supply
GND	GROUND	Ground: Connect to ground when referenced to Vcc
NC	Unused	NC: Pins labeled "NC" stand for "No Connect" and should be left uncommitted.

3. BLOCK DIAGRAM



Note:

- 1: In case of 16-pin SOIC or 24-ball TFBFA, when QE=0 and Dedicated RESET# is Disabled, the pin acts as HOLD# or RESET# and either one can be selected by the P7 bit setting in Read Register. HOLD# will be selected if P7=0 (Default) and RESET# will be selected if P7=1.

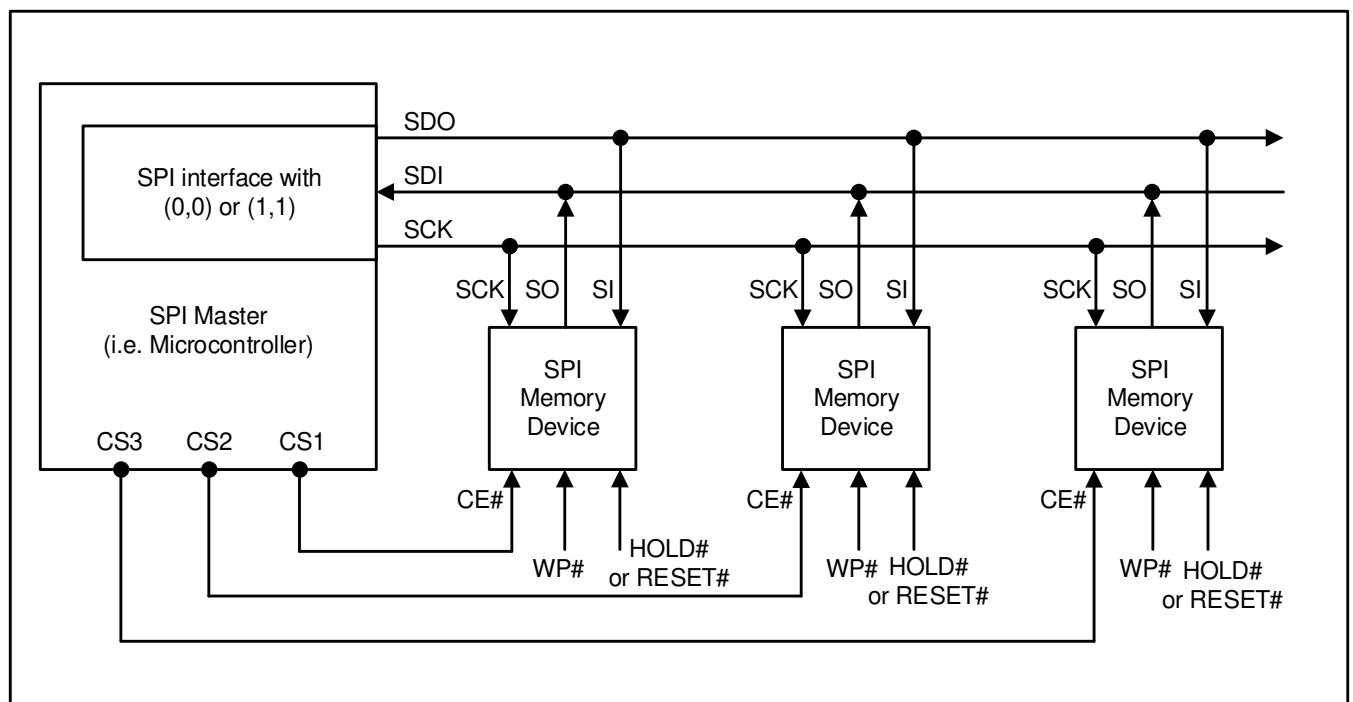
4. SPI MODES DESCRIPTION

Multiple IS25LP512M devices or multiple IS25WP512M devices can be connected on the SPI serial bus and controlled by a SPI Master, i.e. microcontroller, as shown in Figure 4.1. The devices support either of two SPI modes:

- Mode 0 (0, 0)
- Mode 3 (1, 1)

The difference between these two modes is the clock polarity. When the SPI master is in stand-by mode, the serial clock remains at “0” (SCK = 0) for Mode 0 and the clock remains at “1” (SCK = 1) for Mode 3. Please refer to Figure 4.2 and Figure 4.3 for SPI and QPI mode. In both modes, the input data is latched on the rising edge of Serial Clock (SCK), and the output data is available from the falling edge of SCK.

Figure 4.1 Connection Diagram among SPI Master and SPI Slaves (Memory Devices)



Notes:

1. In case of 16-pin SOIC and 24-ball TFBGA, dedicated RESET# is supported.
2. SI and SO pins become bidirectional IO0 and IO1 respectively during Dual I/O mode and SI, SO, WP#, and HOLD# pins become bidirectional IO0, IO1, IO2, and IO3 respectively during Quad I/O or QPI mode.

Figure 4.2 SPI Mode Support

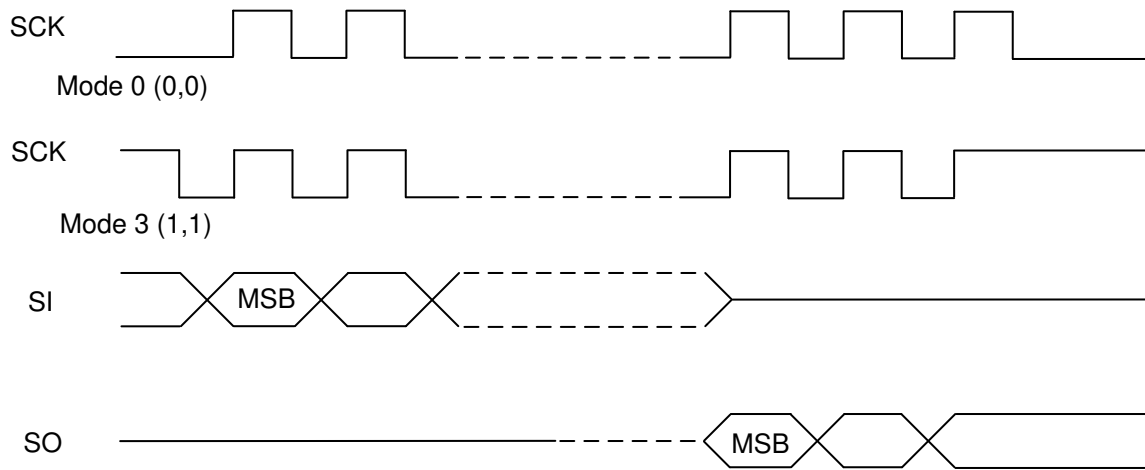
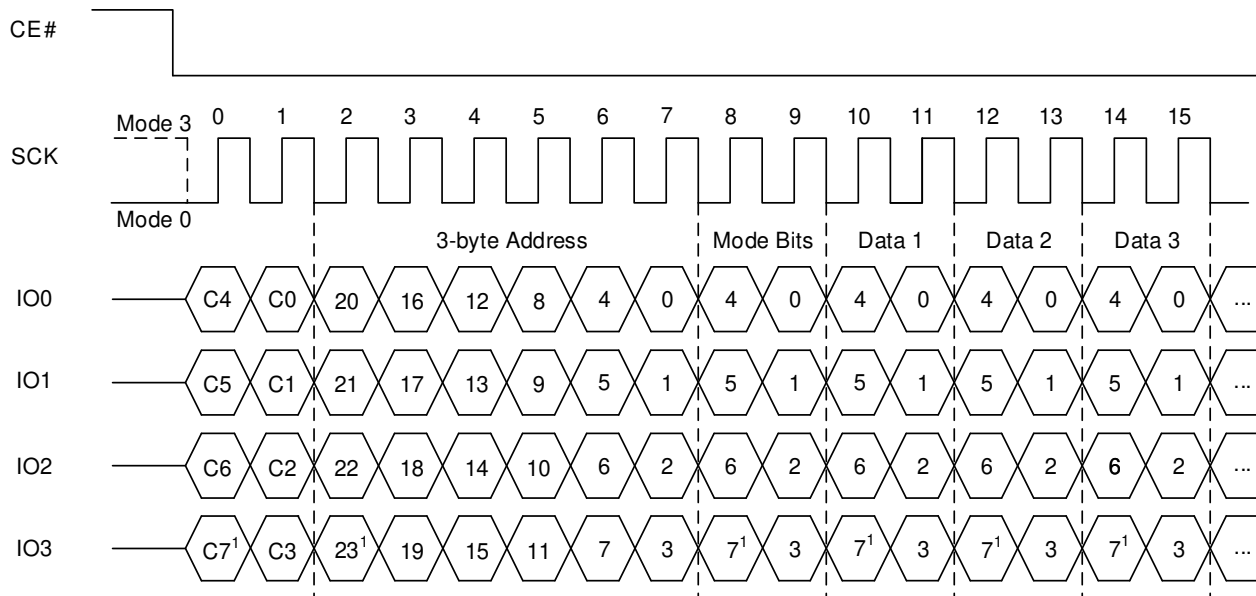


Figure 4.3 QPI Mode Support



Note1: MSB (Most Significant Bit)

5. SYSTEM CONFIGURATION

The memory array is divided into uniform 4 Kbyte sectors or uniform 32/64 Kbyte blocks (a block consists of eight/sixteen adjacent sectors respectively).

Also optional uniform 32/256 Kbyte blocks are available with 512B page size. See ordering table for more detail information.

Table 5.1 illustrates the memory map of the device. The Status Register controls how the memory is protected.

5.1 BLOCK/SECTOR ADDRESSES

Table 5.1 Block/Sector Addresses (Block Size = 32KB/64KB)

Memory Density	Block No. (64Kbyte)	Block No. (32Kbyte)	Sector No.	Sector Size (Kbyte)	Address Range
512Mb	Block 0	Block 0	Sector 0	4	000 0000h – 000 0FFFh
		Block 1	:	:	:
			Sector 15	4	000 F000h – 000 FFFFh
	Block 1	Block 2	Sector 16	4	001 0000h – 001 0FFFh
		Block 3	:	:	:
			Sector 31	4	001 F000h – 001 FFFFh
	Block 2	Block 4	Sector 32	4	002 0000h – 002 0FFFh
		Block 5	:	:	:
			Sector 47	4	002 F000h – 002 FFFFh
	:	:	:	:	:
	Block 510	Block 1020	Sector 8160	4	1FE 0000h – 1FE 0FFFh
		Block 1021	:	:	:
			Sector 8175	4	1FE F000h – 1FE FFFFh
	Block 511	Block 1022	Sector 8176	4	1FF 0000h – 1FF 0FFFh
		Block 1023	:	:	:
			Sector 8191	4	1FF F000h – 1FF FFFFh
	:	:	:	:	:
	Block 1022	Block 2044	Sector 16352	4	3FE 0000h – 3FE 0FFFh
		Block 2045	:	:	:
			Sector 16367	4	3FE F000h – 3FE FFFFh
	Block 1023	Block 2046	Sector 16368	4	3FF 0000h – 3FF 0FFFh
		Block 2047	:	:	:
			Sector 16383	4	3FF F000h – 3FF FFFFh

Table 5.2 Block/Sector Addresses (Block Size = 32KB/256KB)

Memory Density	Block No. (256Kbyte)	Block No. (32Kbyte)	Sector No.	Sector Size (Kbyte)	Address Range
512Mb	Block 0	Block 0	Sector 0	4	000 0000h – 000 0FFFh
			:	:	:
		Block 1	:	:	:
			Sector 15	4	000 F000h – 000 FFFFh
		Block 2	Sector 16	4	001 0000h – 001 0FFFh
			:	:	:
		Block 3	:	:	:
			Sector 31	4	001 F000h – 001 FFFFh
	Block 4	Sector 32	4	002 0000h – 002 0FFFh	
		:	:	:	
	Block 5	:	:	:	
		Sector 47	4	002 F000h – 002 FFFFh	
	Block 6	Sector 48		003 0000h – 003 0FFFh	
		:	:	:	
	Block 7	:	:	:	
		Sector 63		003 F000h – 003 FFFFh	
	:	:	:	:	:
	Block 127	Block 1016	Sector 8128	4	1FC 0000h – 1FC 0FFFh
			:	:	:
		Block 1017	:	:	:
			Sector 8143	4	1FC F000h – 1FC FFFFh
		:	:	:	:
		Block 1022	Sector 8176	4	1FF 0000h – 1FF 0FFFh
			:	:	:
		Block 1023	:	:	:
	Sector 8191		4	1FF F000h – 1FF FFFFh	
	:	:	:	:	:
	Block 255	Block 2040	Sector 16320	4	3FC 0000h – 3FC 0FFFh
			:	:	:
		Block 2041	:	:	:
			Sector 16335	4	3FC F000h – 3FC FFFFh
		Block 2042	Sector 16336		3FD 0000h – 3FD 0FFFh
:			:	:	
Block 2043		:	:	:	
		Sector 16351		3FD F000h – 3FD FFFFh	
Block 2044		Sector 16352	4	3FE 0000h – 3FE 0FFFh	
		:	:	:	
Block 2045	:	:	:		
	Sector 16367	4	3FE F000h – 3FE FFFFh		
Block 2046	Sector 16368	4	3FF 0000h – 3FF 0FFFh		
	:	:	:		
Block 2047	:	:	:		
	Sector 16383	4	3FF F000h – 3FF FFFFh		

5.2 SERIAL FLASH DISCOVERABLE PARAMETERS

The Serial Flash Discoverable Parameters (SFDP) standard defines the structure of the SFDP database within the memory device. SFDP is the standard of JEDEC JESD216.

The JEDEC-defined header with Parameter ID FF00h and related Basic Parameter Table is mandatory. Additional parameter headers and tables are optional.

Table 5.3 Signature and Parameter Identification Data Values

Description		Address (Byte)	Address (Bit)	Data
SFDP Signature		00h	7:0	53h
		01h	15:8	46h
		02h	23:16	44h
		03h	31:24	50h
SFDP Revision	Minor	04h	7:0	06h
	Major	05h	15:8	01h
Number of Parameter Headers (NPH)		06h	23:16	01h
Unused		07h	31:24	FFh
Parameter ID LSB		08h	7:0	00h
Parameter Minor Revision		09h	15:8	06h
Parameter Major Revision		0Ah	23:16	01h
Parameter Table Length (in DWPRDs)		0Bh	31:24	10h
Basic Flash Parameter Table Pointer (PTP)		0Ch	7:0	30h
		0Dh	15:8	00h
		0Eh	23:16	00h
Parameter ID MSB		0Fh	31:24	FFh
Parameter ID LSB		10h	7:0	84h
Parameter Minor Revision		11h	15:8	0h
Parameter Major Revision		12h	23:16	1h
Parameter Table Length (in DWPRDs)		13h	31:24	02h
Parameter Table Pointer (PTP)		14h	7:0	80h
		15h	15:8	00h
		16h	23:16	00h
Parameter ID MSB		17h	31:24	FFh

Table 5.4 JEDEC Basic Flash Parameter Table

Description	Address (Byte)	Address (Bit)	Data
Minimum Sector Erase Sizes	30h	1:0	01b
Write Granularity		2	1b
Volatile Status Register Block Protect bits		3	0b
Write Enable Instruction Select for writing to Volatile Status Register		4	0b
Unused		7:5	111b
4KB Erase Instruction	31h	15:8	20h
Supports (1-1-2) Fast Read	32h	16	1b
Address Bytes		18:17	01b
Supports Double Transfer Rate (DTR) Clocking		19	1b
Supports (1-2-2) Fast Read		20	1b
Supports (1-4-4) Fast Read		21	1b
Supports (1-1-4) Fast Read		22	1b
Unused		23	1b
Reserved	33h	31:24	FFh
Flash memory Density (bits)	34h	7:0	FFh
	35h	15:8	FFh
	36h	23:16	FFh
Flash memory Density	37h	31:24	1Fh
1-4-4 Fast Read Wait Cycle Count	38h	4:0	00100b
1-4-4 Fast Read Mode bit Cycle Count		7:5	010b
1-4-4 Fast Read Instruction	39h	15:8	EBh
1-1-4 Fast Read Wait Cycle Count	3Ah	20:16	01000b
1-1-4 Fast Read Mode bit Cycle Count		23:21	000b
1-1-4 Fast Read Instruction	3Bh	31:24	6Bh
1-1-2 Fast Read Wait Cycle Count	3Ch	4:0	01000b
1-1-2 Fast Read Mode bit Cycle Count		7:5	000b
1-1-2 Fast Read Instruction	3Dh	15:8	3Bh
1-2-2 Fast Read Wait Cycle Count	3Eh	20:16	00000b
1-2-2 Fast Read Mode bit Cycle Count		23:21	100b
1-2-2 Fast Read Instruction	3Fh	31:24	BBh

Table 5.4 JEDEC Basic Flash Parameter Table (Continued)

Description	Address (Byte)	Address (Bit)	Data
Supports (2-2-2) Fast Read	40h	0	0b
Reserved		3:1	111b
Supports (4-4-4) Fast Read		4	1b
Reserved		7:5	111b
Reserved	43:41h	31:8	FFFFFFh
Reserved	45:44h	15:0	FFFFh
2-2-2 Fast Read Wait Cycle Count	46h	20:16	00000b
2-2-2 Fast Read Mode bit Cycle Count		23:21	000b
2-2-2 Fast Read Instruction	47h	31:24	FFh
Reserved	49:48h	15:0	FFFFh
4-4-4 Fast Read Wait Cycle Count	4Ah	20:16	00100b
4-4-4 Fast Read Mode bit Cycle Count		23:21	010b
4-4-4 Fast Read Instruction	4Bh	31:24	EBh
Erase Type 1 Size (4KB)	4Ch	7:0	0Ch
Erase Type 1 Instruction	4Dh	15:8	20h
Erase Type 2 Size (32KB)	4Eh	23:16	0Fh
Erase Type 2 Instruction	4Fh	31:24	52h
Erase Type 3 Size (64KB)	50h	7:0	10h(00h ⁽¹⁾)
Erase Type 3 Instruction	51h	15:8	D8h(FFh ⁽¹⁾)
Erase Type 4 Size (256KB)	52h	23:16	00h(12h ⁽¹⁾)
Erase Type 4 Instruction	53h	31:24	FFh(D8h ⁽¹⁾)
Multiplier from typical erase time to maximum erase time	57:54h	3:0	0010b
Sector Type 1 ERASE time (typ)		8:4	00110b
		10:9	01b
Sector Type 2 ERASE time (typ)		15:11	01000b
		17:16	01b
Sector Type 3 ERASE time (typ)		22:18	01010b (00000b ⁽¹⁾)
		24:23	01b(00b ⁽¹⁾)
Sector Type 4 ERASE time (typ)		29:25	00000b (00101b ⁽¹⁾)
	31:30	00b(10b ⁽¹⁾)	

Note:

1. Only for option K (256KB Block Size instead of 64KB)

Table 5.4 JEDEC Basic Flash Parameter Table (Continued)

Description	Address (Byte)	Address (Bit)	Data
Multiplier from typical time to maximum time for page or byte PROGRAM	58h	3:0	0010b
Page size		7:4	1000b (1001b ⁽¹⁾)
Page Program Typical time	5Ah:59h	12:8	11000b (00100b ⁽¹⁾)
		13	0b (1b ⁽¹⁾)
17:14		0111b	
Byte Program Typical time, first byte		18	0b
Byte Program Typical time, additional byte		22:19	0000b
		23	0b
Chip Erase, Typical time		5Bh	28:24
Units	30:29		10b
Reserved	31		1b
Prohibited Operations During Program Suspend	5Ch	3:0	1100b
Prohibited Operations During Erase Suspend		7:4	1110b
Reserved	5Eh:5Dh	8	1b
Program Resume to Suspend Interval		12:9	0110b
Suspend in-progress program max latency		17:13	01100b
		19:18	10b
Erase Resume to Suspend Interval		23:20	0110b
Suspend in-progress erase max latency	5Fh	28:24	01100b
		30:29	10b
Suspend /Resume supported		31	0b
Program Resume Instruction	60h	7:0	7Ah
Program Suspend Instruction	61h	15:8	75h
Resume Instruction	62h	23:16	7Ah
Suspend Instruction	63h	31:24	75h
Reserved	64h	1:0	11b
Status Register Polling Device Busy		7:2	111101b

Note:

1. Only for option K (512B Page Size instead of 256B)

Table 5.4 JEDEC Basic Flash Parameter Table (Continued)

Description	Address (Byte)	Address (Bit)	Data	
Exit Deep Power-down to next operation delay	3V	67h:65h	12:8	00010b
	1.8V			00100b
Exit Deep Power-down to next operation delay Units			14:13	01b
Exit Deep Power-down Instruction			22:15	ABh
Enter Deep Power-down Instruction			30:23	B9h
Deep Power-down Supported			31	0b
4-4-4 mode disable sequences (QPIDI)	69h:68h	3:0	1010b	
4-4-4 mode enable sequences (QPIEN)		8:4	00100b	
0-4-4 Mode Supported		9	1b	
0-4-4 Mode Exit Method		15:10	110000b	
0-4-4 Mode Entry Method:	6Ah	19:16	1100b	
Quad Enable Requirements (QER)		22:20	010b	
Hold or RESET Disable		23	0b	
Reserved	6Bh	31:24	FFh	
Volatile or Non-Volatile Register and Write Enable (WREN) Instruction for Status Register 1	6Ch	6:0	1101000b	
Reserved		7	1b	
Soft Reset and Rescue Sequence Support	6Eh:6Dh	13:8	110000b	
Exit 4-Byte Addressing		23:14	1111101000b	
Enter 4-Byte Addressing	6Fh	31:24	10101001b	

Table 5.5. Parameter Table (1): 4-byte Address Instruction Tables

Description	Address (Byte)	Address (Bit)	Data
Support for (1-1-1) READ Command, Instruction = 13h	80h	0	1b
Support for (1-1-1) FAST_READ Command, Instruction = 0Ch		1	1b
Support for (1-1-2) FAST_READ Command, Instruction = 3Ch		2	1b
Support for (1-2-2) FAST_READ Command, Instruction = BCh		3	1b
Support for (1-1-4) FAST_READ Command, Instruction = 6Ch		4	1b
Support for (1-4-4) FAST_READ Command, Instruction = ECh		5	1b
Support for (1-1-1) Page Program Command, Instruction = 12h		6	1b
Support for (1-1-4) Page Program Command, Instruction = 34h		7	1b
Support for (1-4-4) Page Program Command, Instruction = 3Eh	81h	8	0b
Support for Erase Command-Type 1		9	1b
Support for Erase Command-Type 2		10	1b
Support for Erase Command-Type 3		11	1b (0b ⁽¹⁾)
Support for Erase Command-Type 4		12	0b (1b ⁽¹⁾)
Support for (1-1-1) DTR_READ Command, Instruction = 0Eh		13	1b
Support for (1-2-2) DTR_READ Command, Instruction = BEh		14	1b
Support for (1-4-4) DTR_READ Command, Instruction = EEh		15	1b
Support for volatile individual sector lock Read Command (E0h)	82h	16	1b
Support for volatile individual sector lock Write Command (E1h)		17	1b
Support for non-volatile individual sector lock Read Command (E2h)		18	1b
Support for non-volatile individual sector lock Write Command (E3h)		19	1b
Reserved		23:20	1111b
Reserved	83h	31:24	FFh
Sector Erase Instruction for Sector Type 1	84h	7:0	21h
Sector Erase Instruction for Sector Type 2	85h	15:8	5Ch
Sector Erase Instruction for Sector Type 3	86h	23:16	DCh (FFh ⁽¹⁾)
Sector Erase Instruction for Sector Type 4	87h	31:24	FFh (DCh ⁽¹⁾)

Note:

1. Only for option K (256KB Block Size instead of 64KB)

6. REGISTERS

The device has many sets of Registers such as Status, Function, Read, AutoBoot, and so on. When the register is read continuously, the same data is output repeatedly until CE# goes HIGH.

6.1 STATUS REGISTER

Status Register Format and Status Register Bit Definitions are described in Tables 6.1 & 6.2. Status Read Register consist of a pair of writable non-volatile register and volatile register, respectively. During power up sequence, volatile register will be loaded with the value of non-volatile value.

But only volatile Status Register is readable with Read Status Register Operation (RDSR, 05h)

Table 6.1 Status Register Format

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	SRWD	QE	BP3	BP2	BP1	BP0	WEL	WIP
Default	0	0	0	0	0	0	0	0

Table 6.2 Status Register Bit Definition

Bit	Name	Definition	Read-/Write	Type
Bit 0	WIP	Write In Progress Bit: "0" indicates the device is ready (default) "1" indicates a write cycle is in progress and the device is busy	R	Volatile
Bit 1	WEL	Write Enable Latch: "0" indicates the device is not write enabled (default) "1" indicates the device is write enabled	R/W ¹	Volatile
Bit 2	BP0	Block Protection Bit: (See Tables 6.4 for details) "0" indicates the specific blocks are not write-protected (default) "1" indicates the specific blocks are write-protected	R/W	Non-Volatile and Volatile
Bit 3	BP1			
Bit 4	BP2			
Bit 5	BP3			
Bit 6	QE	Quad Enable bit: "0" indicates the Quad output function disable (default) "1" indicates the Quad output function enable	R/W	Non-Volatile and Volatile
Bit 7	SRWD	Status Register Write Disable: (See Table 7.1 for details) "0" indicates the Status Register is not write-protected (default) "1" indicates the Status Register is write-protected	R/W	Non-Volatile and Volatile

Note: WEL bit can be written by WREN and WRDI commands, but cannot by WRSR command.

The BP0, BP1, BP2, BP3, QE, and SRWD are non-volatile and volatile memory cells that can be written by a Write Status Register (WRSR) instruction. The default value of the BP0, BP1, BP2, BP3, QE, and SRWD bits were set to "0" at factory. Only volatile Status Register is readable with Read Status Register Operation (RDSR, 05h)

The function of Status Register bits are described as follows:

WIP bit: Write In Progress (WIP) is read-only, and can be used to detect the progress or completion of a Program, Erase, Write/Set Non-Volatile/OTP Register, or Gang Sector/Block Lock/Unlock operation. WIP is set to "1" (busy state) when the device is executing the operation. During this time the device will ignore further instructions except for Read Status/Function/Extended Read Register and Software/Hardware Reset instructions. In addition to the instructions, an Erase/Program Suspend instruction also can be executed during a Program or Erase operation. When an operation has completed, WIP is cleared to "0" (ready state) whether the operation is successful or not and the device is ready for further instructions.

WEL bit: Write Enable Latch (WEL) bit indicates the status of the internal write enable latch. When WEL bit is “0”, the internal write enable latch is disabled and the Write operations described in Table 6.3 are inhibited. When WEL bit is “1”, the Write operations are allowed. WEL bit is set by a Write Enable (WREN, 06h) instruction. Most of Write Non-Volatile/Volatile Register, Program and Erase instruction must be preceded by a WREN instruction.

But Write Volatile Status Register does not require to set WEL bit to “1” by WREN (06h) instruction. Instead it requires a Volatile Status Register Write Enable (50h) instruction prior to Write Status Register (01h) instruction. Volatile Status Register Write Enable (50h) instruction does not set the Write Enable Latch (WEL) bit to “1”.

WEL bit can be reset by a Write Disable (WRDI) instruction. It will automatically reset after the completion of any Write Non-Volatile Register, Program and Erase operation.

Table 6.3 Instructions requiring WREN instruction ahead

Instructions must be preceded by the WREN instruction		
Name	Hex Code	Operation
PP	02h	Serial Input Page Program (3-byte or 4-byte Address)
4PP	12h	Serial Input Page Program (4-byte Address)
PPQ	32h/38h	Quad Input Page Program (3-byte or 4-byte Address)
4PPQ	34h/3Eh	Quad Input Page Program (4-byte Address)
SER	D7h/20h	Sector Erase 4KB (3-byte or 4-byte Address)
4SER	21h	Sector Erase 4KB (4-byte Address)
BER32 (32KB)	52h	Block Erase 32KB (3-byte or 4-byte Address)
4BER32 (32KB)	5Ch	Block Erase 32KB (4-byte Address)
BER64 (64KB)	D8h	Block Erase 64KB (3-byte or 4-byte Address)
4BER64 (64KB)	DCh	Block Erase 64KB (4-byte Address)
CER	C7h/60h	Chip Erase
WRSR⁽¹⁾	01h	Write Non-Volatile Status Register
WRFR	42h	Write Function Register
SRPNV	65h	Set Read Parameters (Non-Volatile)
SRPV⁽²⁾	63h	Set Read Parameters (Volatile)
SERPNO	85h	Set Extended Read Parameters (Non-Volatile)
SERPVO	83h	Set Extended Read Parameters (Volatile)
IRER	64h	Erase Information Row
IRP	62h	Program Information Row
WRABR	15h	Write AutoBoot Register
WRBRNO	18h	Write Non-Volatile Bank Address Register
WRBRV⁽²⁾	C5h	Write Volatile Bank Address Register
WRDYB	FBh	Write DYB Register (4-byte Address)
4WRDYB	E1h	Write DYB Register (3-byte or 4-byte Address)
PGPPB	FDh	Write PPB (3-byte or 4-byte Address)
4PGPPB	E3h	Write PPB (4-byte Address)
ERPPB	E4h	Erase PPB
PGASP	2Fh	Program ASP
WRPLB	A6h	Write PPB Lock Bit
SFRZ	91h	Set FREEZE bit
GBLK	7Eh	GANG Sector/Block Lock
GBUN	98h	GANG Sector/Block Unlock
PGPWD	E8h	Program Password
PNVDLR	43h	Program Non-Volatile Data Learning Pattern Register
WRVDLR	4Ah	Program Volatile Data Learning Pattern Register
WRECC	B5h	Write ECC Register

Notes:

1. Volatile Status Register Write Enable (50h) command is required for Write Volatile Status Register operation with WRSR(01) command.
2. C0h command for SRPV operation and 17h command for WRBRV operation do not require WREN command ahead.

BP3, BP2, BP1, BP0 bits: The Block Protection (BP3, BP2, BP1 and BP0) bits are used to define the portion of the memory area to be protected. Refer to Table 6.4 for the Block Write Protection (BP) bit settings. When a defined combination of BP3, BP2, BP1 and BP0 bits are set, the corresponding memory area is protected. Any program or erase operation to that area will be inhibited.

Note: A Chip Erase (CER) instruction will be ignored unless all the Block Protection Bits are “0”s.

SRWD bit: The Status Register Write Disable (SRWD) bit operates in conjunction with the Write Protection (WP#) signal to provide a Hardware Protection Mode. When the SRWD is set to “0”, the Status Register is not write-protected. When the SRWD is set to “1” and the WP# is pulled low (V_{IL}), the bits of Status Register (SRWD, QE, BP3, BP2, BP1, BP0) become read-only, and a WRSR instruction will be ignored. If the SRWD is set to “1” and WP# is pulled high (V_{IH}), the Status Register can be changed by a WRSR instruction.

QE bit: The Quad Enable (QE) is a non-volatile bit in the Status Register that allows quad operation. When the QE bit is set to “0”, the pin WP# and HOLD#/RESET# are enabled. When the QE bit is set to “1”, the IO2 and IO3 pins are enabled.

WARNING: The QE bit must be set to “0” if WP# or HOLD#/RESET# pin (or ball) is tied directly to the power supply.